

# BOLOGNA STATUS REPORT

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LHC RUN Moedal Exposure	EXPOSED AREA	ETCHED AREA	SCANNED AREA	ETCHNG Completion	SCANNING Completion
2009- 2012	7.8 m <sup>2</sup>	7.8 m <sup>2</sup>	7.8 m <sup>2</sup>	✓	✓
2014- 2015	<i>Standard stacks:</i> 10.7 m <sup>2</sup> <i>HCC stacks:</i> 6.2 m <sup>2</sup>	10.7 m <sup>2</sup>  6.2 m <sup>2</sup>	9.0 m <sup>2</sup>  1.5 m <sup>2</sup>	✓	
2016- 2017	<i>Standard stacks:</i> 11.2 m <sup>2</sup> <i>HCC stacks:</i> 9.7 m <sup>2</sup>	8.7 m <sup>2</sup>  -	-  -	end February, 2019	

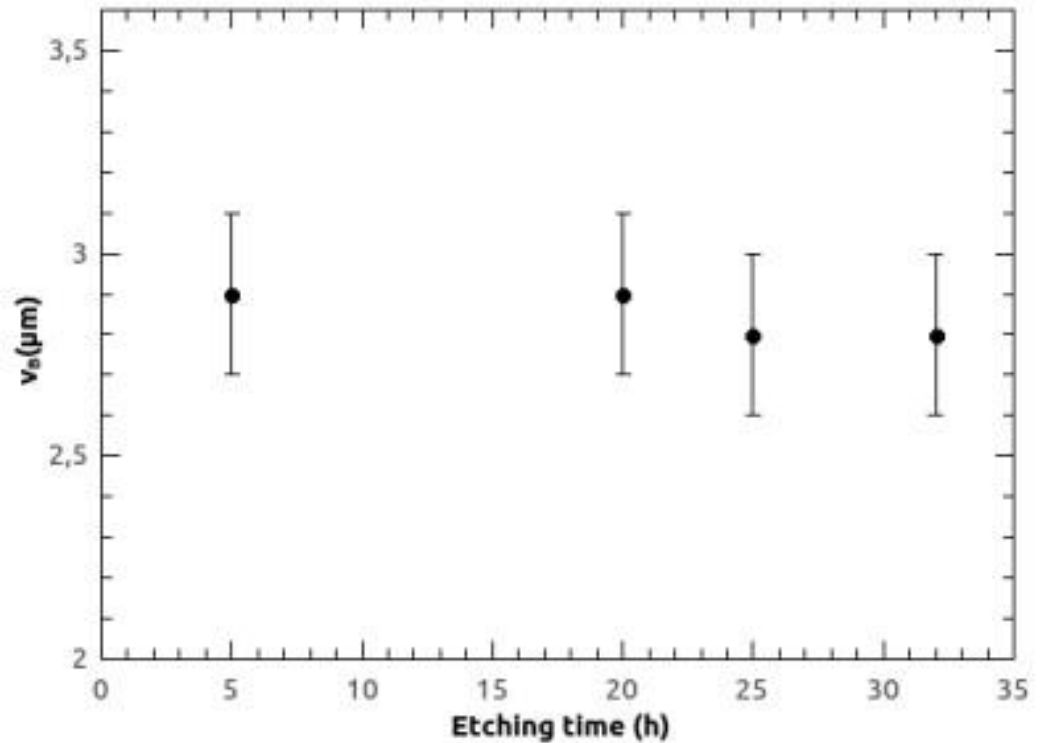
- *Standard stacks:* 24 cm x 24 cm
- *HCC stacks:* 180 cm x 45 cm

## ETCHANT + ETCHING CONDITIONS:

5.5N KOH + 20% denatured Ethanol at 45°C

### Bulk etching rate stability

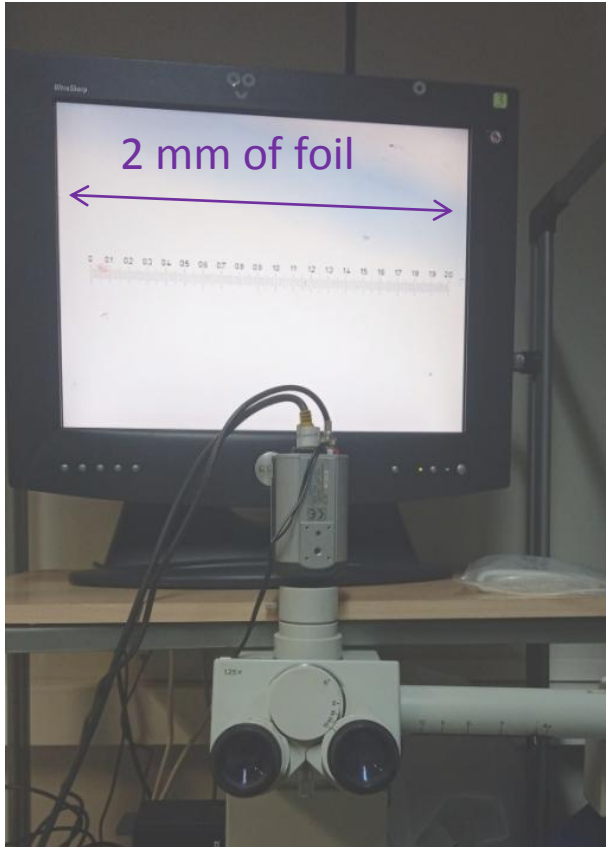
0 – 5 h  
5 – 20 h  
20 – 25 h  
25 – 32 h



- ❑  $v_B$  fairly stable over > 30 h etching
- ❑ Improvement of the etch-pit quality (scope for “faster” scanning)

# “Faster” scanning with Stereo Microscope

## A) Quantitatively



32x magnification:  
FoV  $\approx$  2 mm x 2 mm

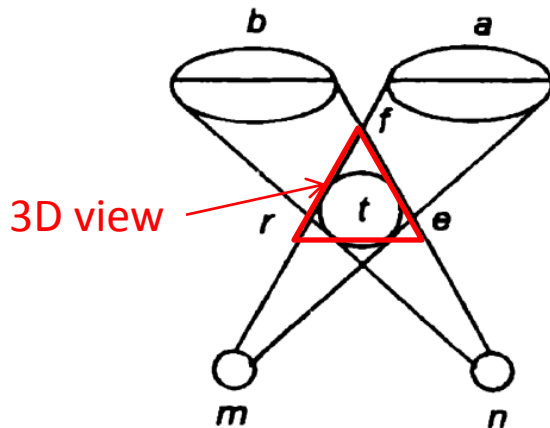
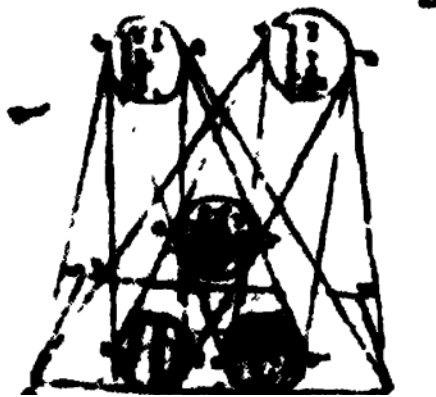


12.5x magnification:  
FoV  $\approx$  1 cm x 1 cm

Field of view: **25 times more**

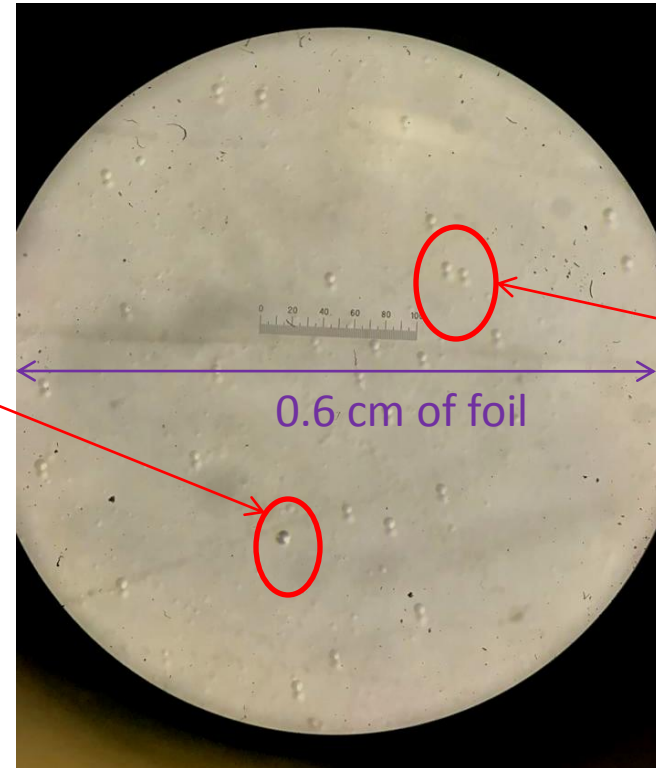
# “Faster” scanning with Stereo Microscope

## B) Qualitatively



Picture adapted from “Leonardo’s Notebook”

“Defect” on the one side of the detector



Etch-pits visible on the both side of the detector

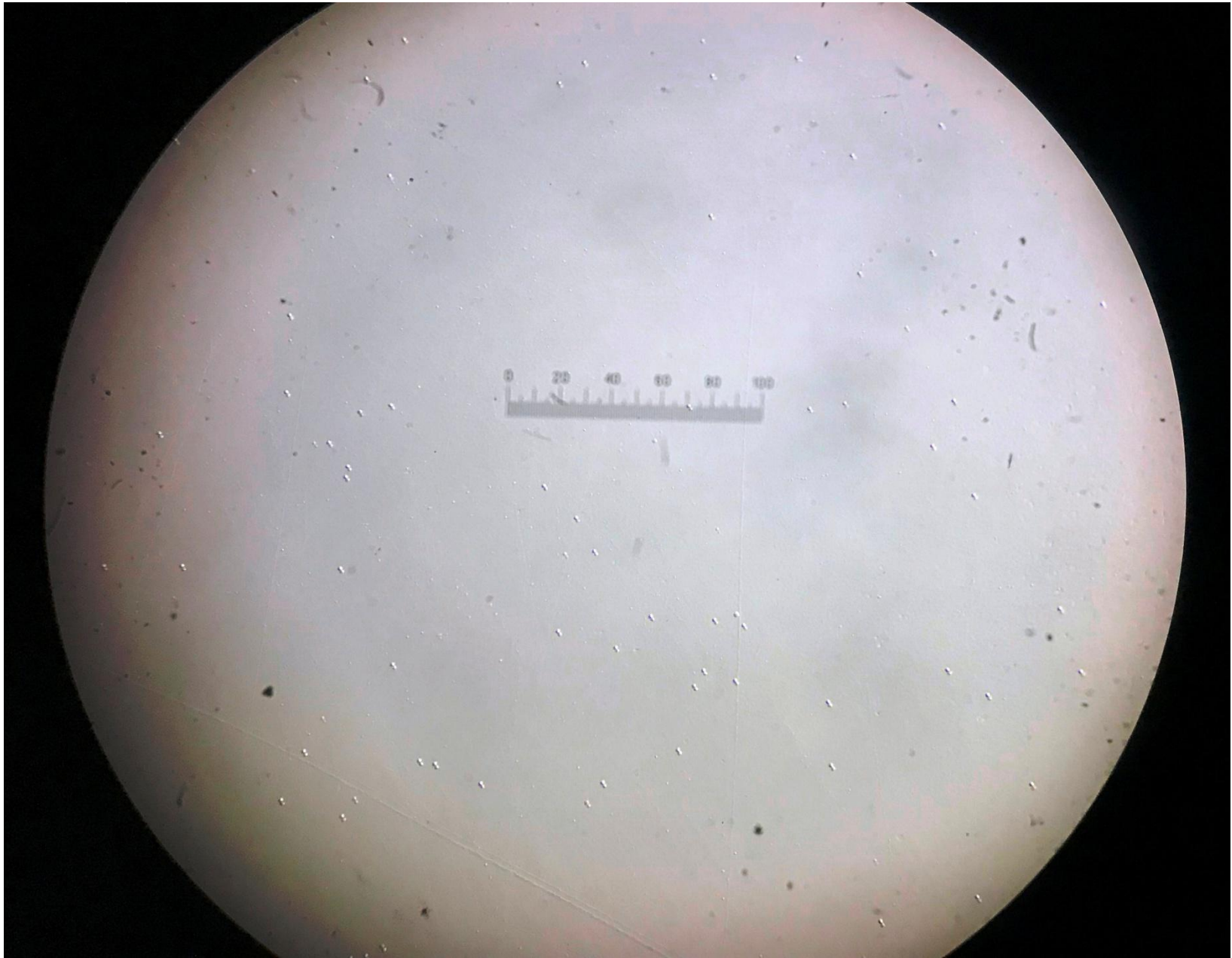
Xe tracks on Makrofol after 20 h of etching

Magnification 20x

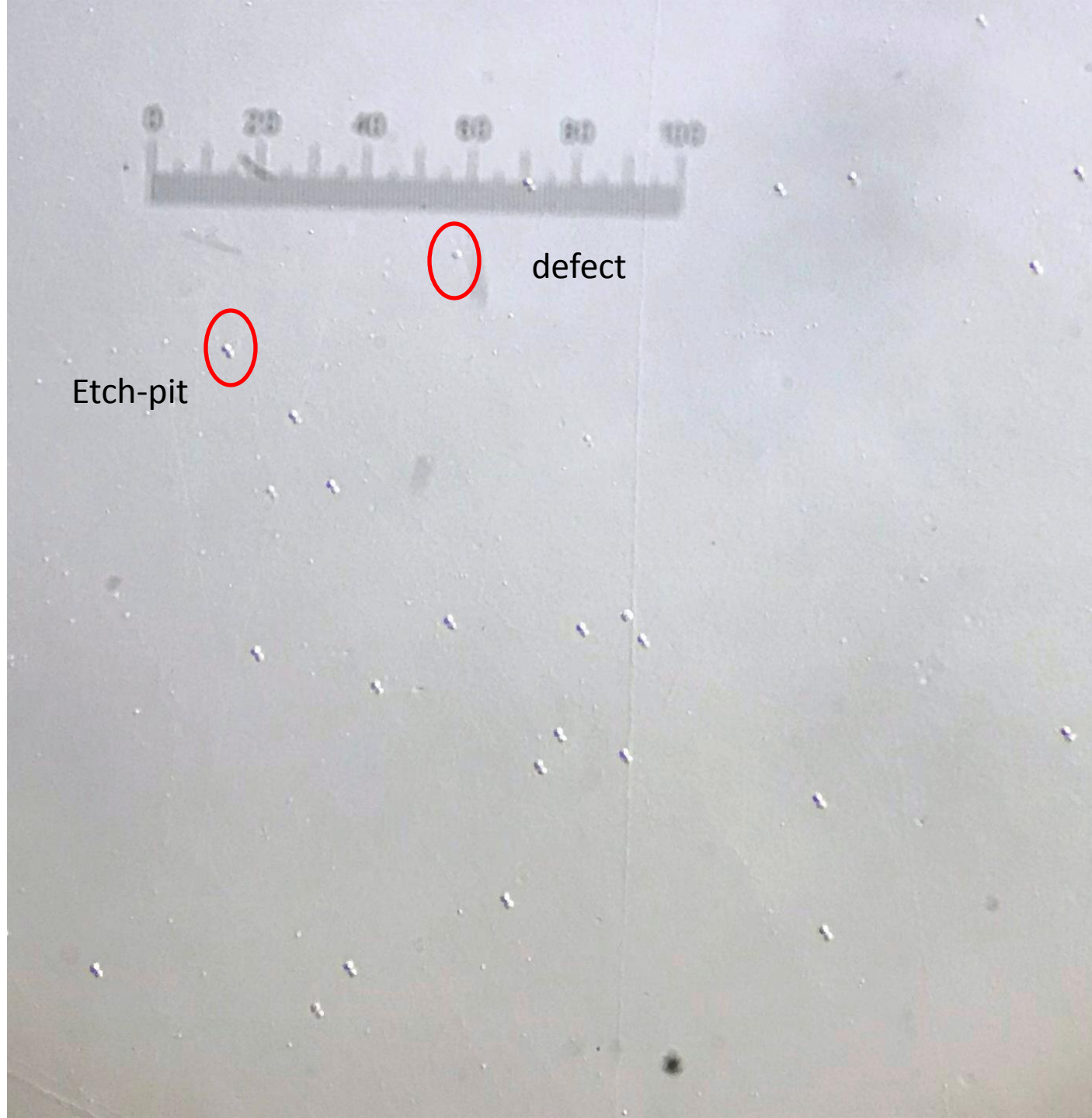
**By observing both sides simultaneously, “true” tracks can be distinguished easily from defects**

thank  
you!

Xe tracks on 15 h etched Makrofol at 12.5x magnification







Etch-pit

defect